

## Advanced Power MOSFET

## IRLW/I530A

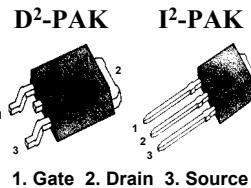
### FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- 175°C Operating Temperature
- Lower Leakage Current : 10 µA (Max.) @  $V_{DS} = 100V$
- Lower  $R_{DS(ON)}$  : 0.101Ω (Typ.)

$BV_{DSS} = 100 V$

$R_{DS(on)} = 0.12\Omega$

$I_D = 14 A$



### Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
$V_{DSS}$	Drain-to-Source Voltage	100	V
$I_D$	Continuous Drain Current ( $T_C=25^\circ C$ )	14	A
	Continuous Drain Current ( $T_C=100^\circ C$ )	9.9	
$I_{DM}$	Drain Current-Pulsed	① 49	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulsed Avalanche Energy	② 261	mJ
$I_{AR}$	Avalanche Current	① 14	A
$E_{AR}$	Repetitive Avalanche Energy	① 6.2	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	③ 6.5	V/ns
$P_D$	Total Power Dissipation ( $T_A=25^\circ C$ ) *	3.8	W
	Total Power Dissipation ( $T_C=25^\circ C$ )	62	W
	Linear Derating Factor	0.41	W/ $^\circ C$
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	- 55 to +175	$^\circ C$
$T_L$	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

### Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	2.41	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient *	--	40	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

\* When mounted on the minimum pad size recommended (PCB Mount).



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## Electrical Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$BV_{DSS}$	Drain-Source Breakdown Voltage	100	--	--	V	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.1	--	$\text{V}/^\circ\text{C}$	$I_D=250\mu\text{A}$ See Fig 7
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.0	--	2.0	V	$V_{DS}=5\text{V}, I_D=250\mu\text{A}$
$I_{GSS}$	Gate-Source Leakage , Forward	--	--	100	nA	$V_{GS}=20\text{V}$
	Gate-Source Leakage , Reverse	--	--	-100		$V_{GS}=-20\text{V}$
$I_{DSS}$	Drain-to-Source Leakage Current	--	--	10	$\mu\text{A}$	$V_{DS}=100\text{V}$
		--	--	100		$V_{DS}=80\text{V}, T_C=150^\circ\text{C}$
$R_{DS(\text{on})}$	Static Drain-Source On-State Resistance	--	--	0.12	$\Omega$	$V_{GS}=5\text{V}, I_D=7\text{A}$ ④
$g_f$	Forward Transconductance	--	10.2	--	$\text{S}$	$V_{DS}=40\text{V}, I_D=7\text{A}$ ④
$C_{iss}$	Input Capacitance	--	580	755	pF	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$ See Fig 5
$C_{oss}$	Output Capacitance	--	140	175		
$C_{rss}$	Reverse Transfer Capacitance	--	60	75		
$t_{d(on)}$	Turn-On Delay Time	--	10	30	ns	$V_{DD}=50\text{V}, I_D=14\text{A}, R_G=6\Omega$ See Fig 13 ④ ⑤
$t_r$	Rise Time	--	11	30		
$t_{d(off)}$	Turn-Off Delay Time	--	29	70		
$t_f$	Fall Time	--	15	40		
$Q_g$	Total Gate Charge	--	16.9	24	nC	$V_{DS}=80\text{V}, V_{GS}=5\text{V}, I_D=14\text{A}$ See Fig 6 & Fig 12 ④ ⑤
$Q_{gs}$	Gate-Source Charge	--	2.7	--		
$Q_{qd}$	Gate-Drain( "Miller" ) Charge	--	9.7	--		

## Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$I_s$	Continuous Source Current	--	--	14	A	Integral reverse pn-diode in the MOSFET
$I_{SM}$	Pulsed-Source Current ①	--	--	49	A	
$V_{SD}$	Diode Forward Voltage ④	--	--	1.5	V	$T_J=25^\circ\text{C}, I_S=14\text{A}, V_{GS}=0\text{V}$
$t_{rr}$	Reverse Recovery Time	--	109	--	ns	$T_J=25^\circ\text{C}, I_F=14\text{A}$ $dI_F/dt=100\text{A}/\mu\text{s}$ ④
$Q_{rr}$	Reverse Recovery Charge	--	0.41	--	$\mu\text{C}$	

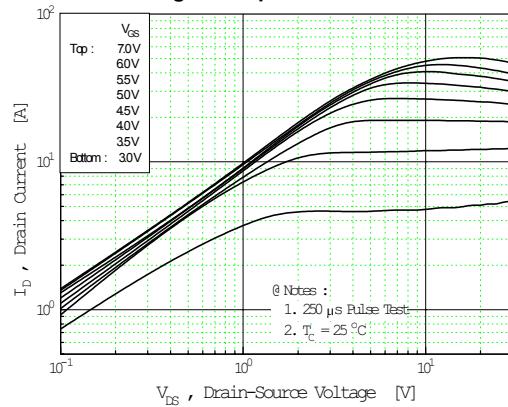
### Notes :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ②  $L=2\text{mH}, I_{AS}=14\text{A}, V_{DD}=25\text{V}, R_G=27\Omega$ , Starting  $T_J=25^\circ\text{C}$
- ③  $I_{SD}\leq 14\text{A}, di/dt\leq 350\text{A}/\mu\text{s}, V_{DD}< BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- ④ Pulse Test : Pulse Width =  $250\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature

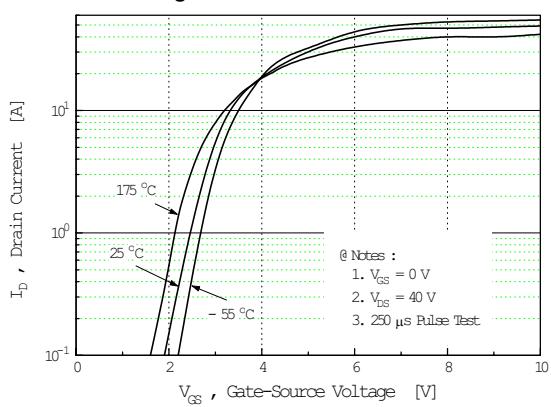
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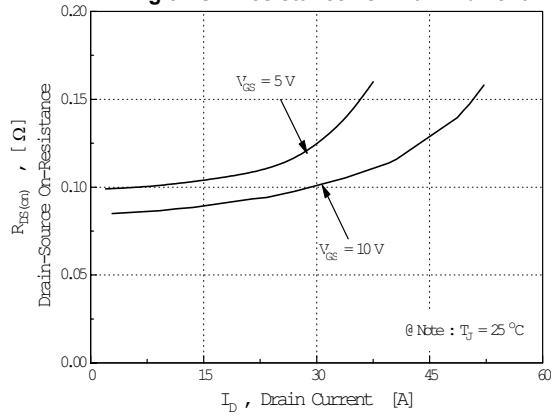
**Fig 1. Output Characteristics**



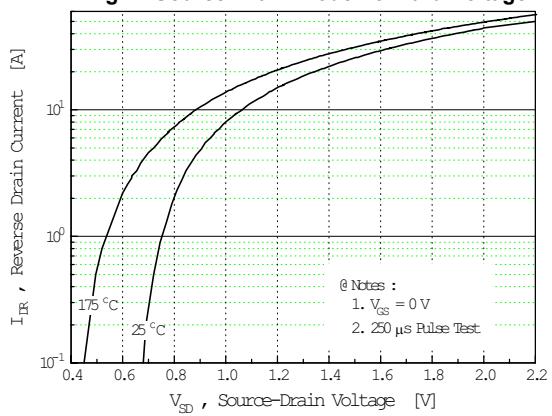
**Fig 2. Transfer Characteristics**



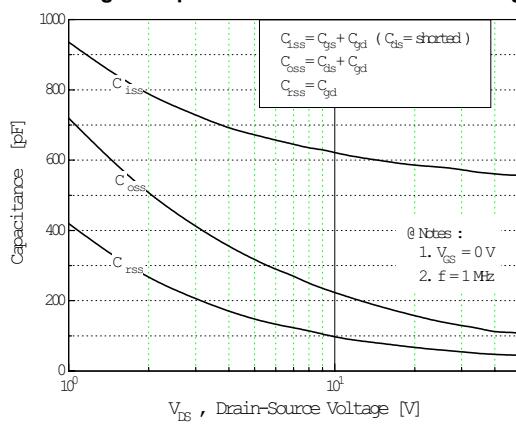
**Fig 3. On-Resistance vs. Drain Current**



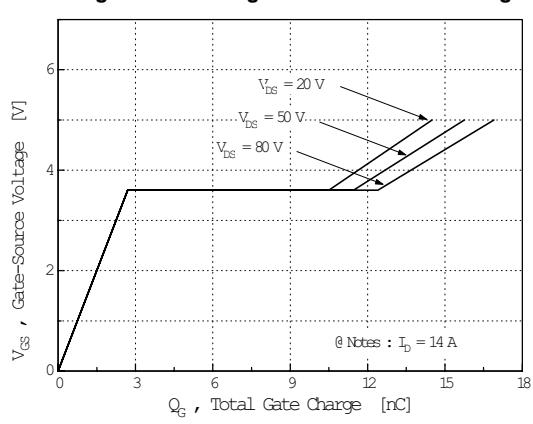
**Fig 4. Source-Drain Diode Forward Voltage**



**Fig 5. Capacitance vs. Drain-Source Voltage**



**Fig 6. Gate Charge vs. Gate-Source Voltage**



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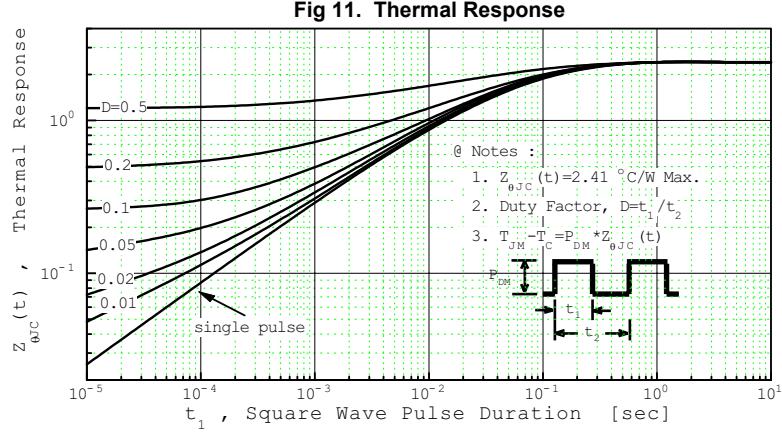
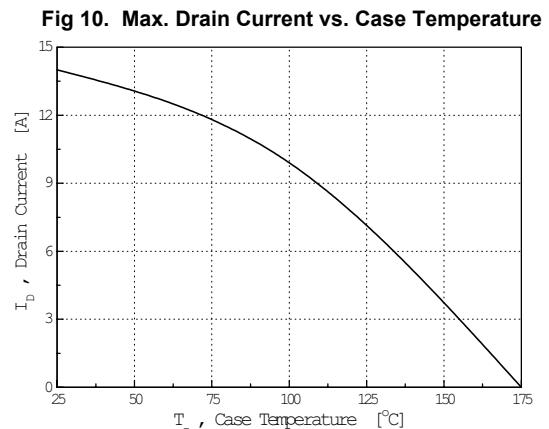
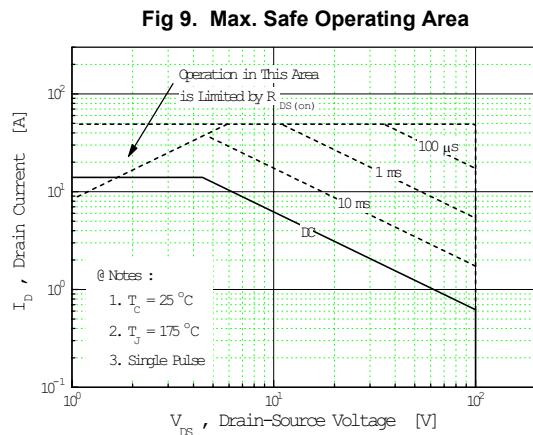
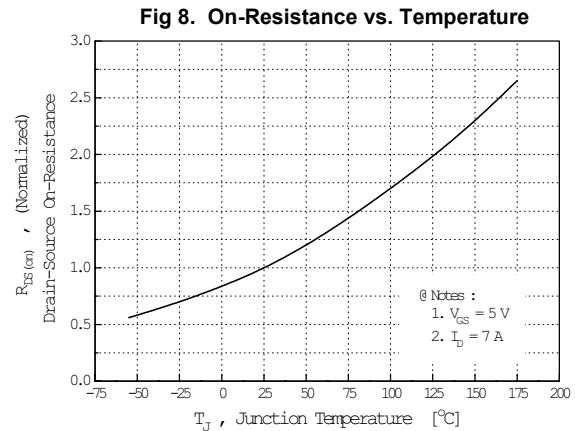
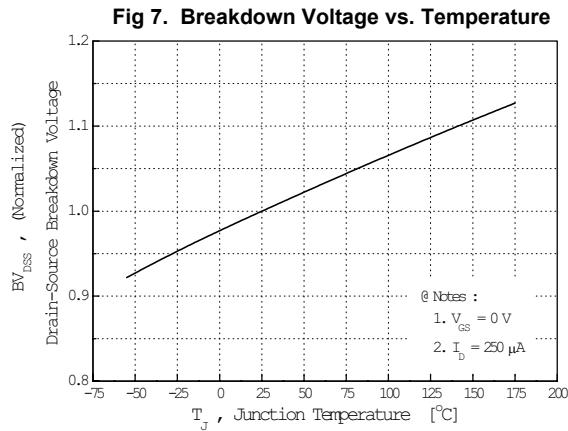


Fig 12. Gate Charge Test Circuit & Waveform

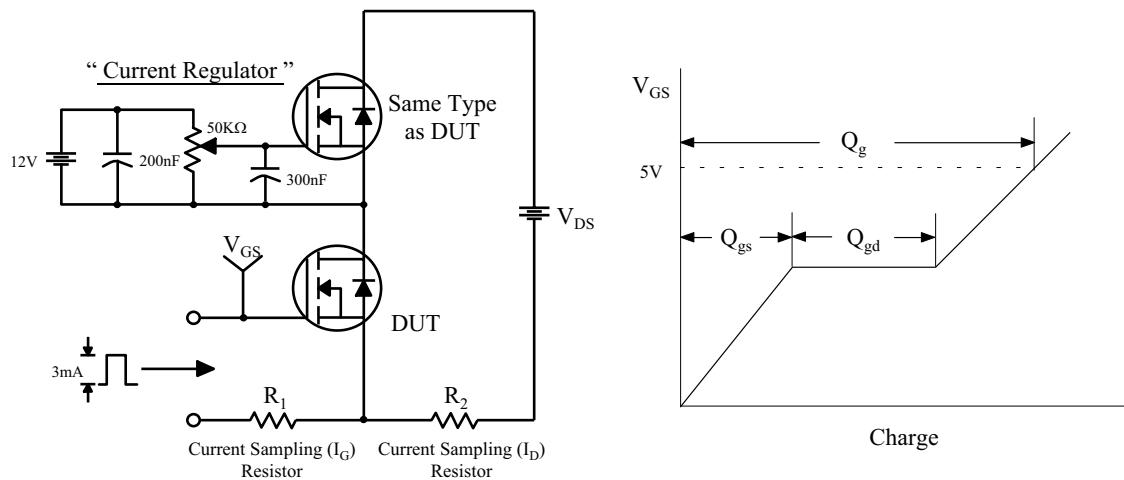


Fig 13. Resistive Switching Test Circuit & Waveforms

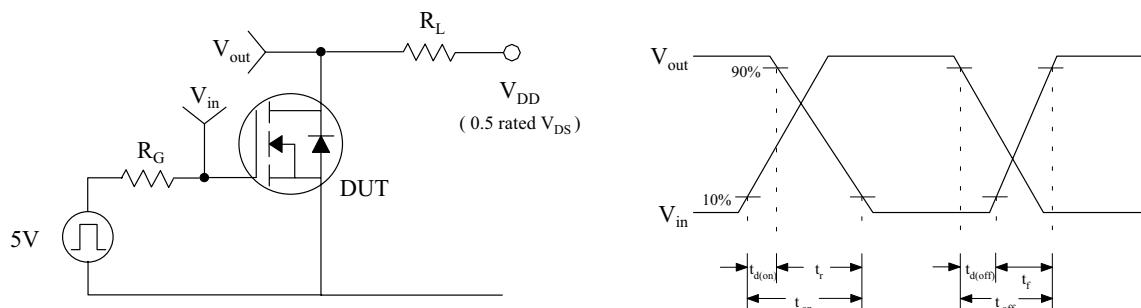


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

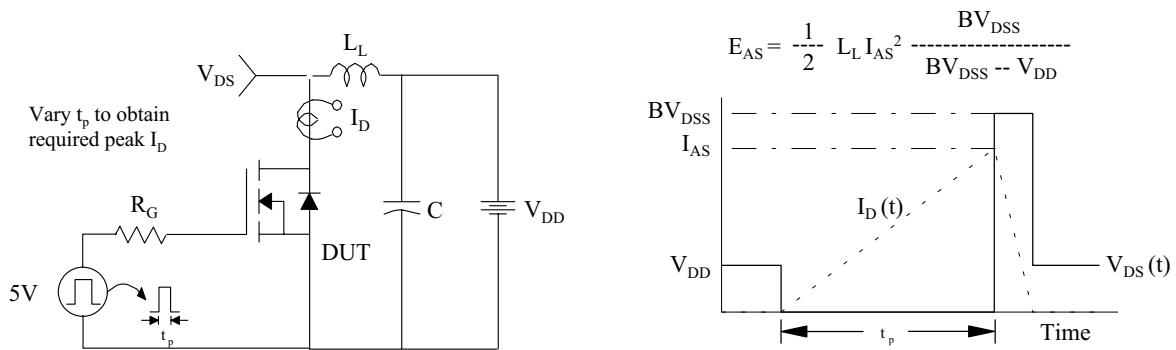


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms

